Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/801,373	BAE ET AL.	•
Examiner	Art Unit	
Khanh V. Nguyen	2817	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	ch History ntout	05/17/06	NKV		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
330/59,86,254,282,308 (Partial Search)	10/3/2005	NKV		
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	10/03/05 (05/17/06)	NKV		
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